

10/566463

IAP5 Rec'd PCT/PTO 30 JAN 2006

Docket No.: 2593-0160PUS1
(PATENT)

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Patent Application of:
Fumio KUROTORI et al.

International Application No.: PCT/JP2004/018652

Application No.: NEW

Art Unit: N/A

Filed: January 30, 2006

Examiner: Not Yet Assigned

For: CONTACT PIN, PROBE CARD AND
ELECTRONIC DEVICE TEST APPARATUS
USING SAME

PRELIMINARY AMENDMENT

MS PCT
Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Sir:

INTRODUCTORY COMMENTS

The following preliminary amendments and remarks are respectfully submitted in connection with the above-identified application.

This amendment includes:

Amendments to the Claims are reflected in the listing of claims which begins on page 2 of this paper.

Remarks/Arguments begin on page 8 of this paper.